INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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Application Number NEW APPLICATION
Filing Date HEREWITH
First Named Inv. ntor Milan K. kta
Attorney Docket Number 1035-BI4282

Sheet 1 of 3 (use as many sheets as necessary)

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¹ Unique citation designation number. 2 See attached Kinds of U.S. Patent Documents. 3 Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). 4 For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. 5 Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. 6 Applicant is to place a check mark here if English language Translation is attached.

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Complete if Known Application Number 10/669,141 Filing Date September 23, 2003 First Named Inventor Milan Kokta Group Art Unit Examiner Name Attorney Docket Number 1035-BI4282

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